



RADIO TEST REPORT

Report No:STS2104043W02

Issued for

DewertOkin GmbH

Weststr. 1, 32278 Kirchlingern, Germany

Product Name:	CU155+
Brand Name:	N/A
Model Name:	A1232
Series Model:	N/A
FCC ID:	O3YCU155PAPL
IC ID:	10744A-CU155PAPL
Test Standard:	FCC Part 15.249
	RSS 210 Issue 10

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Shenzhen STS Test Services Co., Ltd.
A 1/F, Building B, Zhuoke Science Park, No.190 Chongqing Road, HepingShequ,
Fuyong Sub-District, Bao'an District, Shenzhen, Guang Dong, China
TEL: +86-755 3688 6288 FAX: +86-755 3688 6277 E-mail:sts@stsapp.com



**TEST RESULT CERTIFICATION**

Applicant's name.....: DewertOkin GmbH
Address.....: Weststr. 1, 32278 Kirchlingern, Germany
Manufacturer's Name: DewertOkin GmbH
Address.....: Weststr. 1, 32278 Kirchlingern, Germany
Product description
Product Name: CU155+
Brand Name: N/A
Model Name.....: A1232
Series Model: N/A
Test Standards.....: FCC Part15.249
RSS 210 Issue 10
Test procedure : ANSI C63.10-2013
This device described above has been tested by STS, the test results show that the equipment under test (EUT) is in compliance with the FCC&IC requirements. And it is applicable only to the tested sample identified in the report.
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Date of Test :
Date of performance of tests : 21 Aug. 2018~ 30 July 2021
Date of Issue : 30 July 2021
Test Result : **Pass**

Testing Engineer :

(Chris chen)

Technical Manager :

(Sean she)

Authorized Signatory :

(Vita Li)





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**Revision History**

Rev.	Issue Date	Report NO.	Effect Page	Contents
00	31 Aug. 2018	STS1808188W06	ALL	Initial Issue
00	30 July 2021	STS2104043W02	ALL	Add a Chip manufacturer and Power supply circuit changes, updated emission data and standard.





1. SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

FCC Part 15.249 , Subpart C RSS 210 Issue 10			
Standard Section	Test Item	Judgment	Remark
15.207 RSS-Gen Issue 5	Conducted Emission	N/A	
15.203 RSS-Gen Issue 5	Antenna Requirement	Pass	
15.249 RSS 210 Issue 10	Radiated Spurious Emission	Pass	
15.205 RSS-Gen Issue 5	Radiated Band Edge Emission	Pass	
15.249 RSS-Gen Issue 5	Occupied Bandwidth	Pass	
RSS-Gen Issue 5	Frequency Stability	Pass	

NOTE:

(1)" N/A" denotes test is not applicable in this Test Report

(2)All tests are according to ANSI C63.10-2013



1.1 TEST FACTORY

SHENZHEN STS TEST SERVICES CO., LTD

Add. : A 1/F, Building B, Zhuoke Science Park, No.190 Chongqing Road, HepingShequ, Fuyong Sub-District, Bao'an District, Shenzhen, Guang Dong, China

FCC test Firm Registration Number: 625569

IC test Firm Registration Number: 12108A

A2LA Certificate No.: 4338.01

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately **95 %**.

No.	Item	Uncertainty
1	RF output power, conducted	$\pm 0.68\text{dB}$
2	Unwanted Emissions, conducted	$\pm 2.988\text{dB}$
3	All emissions, radiated 9K-30MHz	$\pm 2.84\text{dB}$
4	All emissions, radiated 30M-1GHz	$\pm 4.39\text{dB}$
5	All emissions, radiated 1G-6GHz	$\pm 5.10\text{dB}$
6	All emissions, radiated >6G	$\pm 5.48\text{dB}$
7	Conducted Emission (9KHz-150KHz)	$\pm 2.79\text{dB}$
8	Conducted Emission (150KHz-30MHz)	$\pm 2.80\text{dB}$



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Product Name/PMN	CU155+	
Trade Name	N/A	
Model Name/HVIN	A1232	
Series Model	N/A	
Model Difference	N/A	
Product Description	The EUT is a CU155+	
	Operation Frequency:	2403-2480MHz
	Modulation Type:	GFSK
	Antenna Designation:	PCB Antenna
	Antenna Gain(Peak):	0 dBi
	Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.	
Channel List	Please refer to the Note 2.	
Power Rating	Input: DC 30V, 6A max Output: DC 30V	
Hardware version number	1003841	
Software version number	R33	
Radio Hardware version	1003841	
Radio Software version/FVIN	R33	
Serial Numbers		
Test Software	putty-0.70cn	

Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.



2.

Channel List							
Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
01	2403	22	2424	43	2445	64	2466
02	2404	23	2425	44	2446	65	2467
03	2405	24	2426	45	2447	66	2468
04	2406	25	2427	46	2448	67	2469
05	2407	26	2428	47	2449	68	2470
06	2408	27	2429	48	2450	69	2471
07	2409	28	2430	49	2451	70	2472
08	2410	29	2431	50	2452	71	2473
09	2411	30	2432	51	2453	72	2474
10	2412	31	2433	52	2454	73	2475
11	2413	32	2434	53	2455	74	2476
12	2414	33	2435	54	2456	75	2477
13	2415	34	2436	55	2457	76	2478
14	2416	35	2437	56	2458	77	2479
15	2417	36	2438	57	2459	78	2480
16	2418	37	2439	58	2460		
17	2419	38	2440	59	2461		
18	2420	39	2441	60	2462		
19	2421	40	2442	61	2463		
20	2422	41	2443	62	2464		
21	2423	42	2444	63	2465		

3. Table for Filed Antenna

Ant.	Brand	Model Name	Antenna Type	Connector	Gain (dBi)	NOTE
1	N/A	A1232	PCB Antenna	N/A	0	Antenna



2.2 DESCRIPTION OF TEST MODES

For conducted test items and radiated spurious emissions

Each of these EUT operation mode(s) or test configuration mode(s) mentioned below was evaluated respectively..

Pretest Mode	Description	Data/Modulation
Mode 1	TX CH01	GFSK
Mode 2	TX CH38	GFSK
Mode 3	TX CH78	GFSK

Note:

(1) All above mode have been measurement, only worst data was reported.

(2) We have be tested for all avaiable U.S. voltage and frequencies(For 120V,50/60Hz and 240V, 50/60Hz) for which the device is capable of operation, and the worst case of 120V,50/60Hz is shown in the report

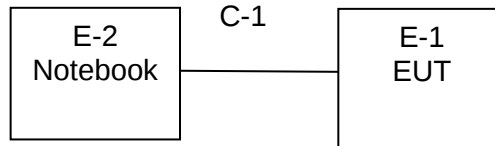
For AC Conducted Emission

Test Case	
AC Conducted Emission	Mode 4 : Keeping TX

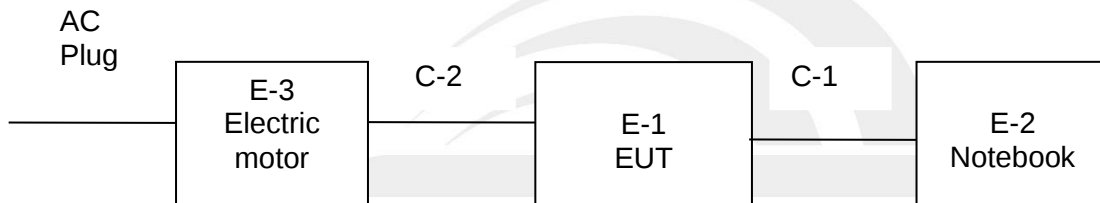
2.3 BLOCK DIGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED

During testing channel & power controlling software provided by the customer was used to control the operating channel as well as the output power level. The RF output power selection is for the setting of RF output power expected by the customer and is going to be fixed on the firmware of the final end product power parameters

Radiated Spurious Emission Test



Conduction Test Set



Note: The EUT doesn't connect directly to the computer, Is through the tool board welding PCB and computer connection, and Continue to transmit.



2.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Serial No.	Note
E-2	Notebook	HP	500-320cx	N/A	N/A
E-3	Electric motor	N/A	N/A	N/A	N/A

Item	Shielded Type	Ferrite Core	Length	Note
C-1	USB Cable	NO	100cm	N/A
C-2	DC Cable	NO	110cm	N/A

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in 『Length』 column.



2.5 EQUIPMENTS LIST FOR ALL TEST ITEMS

Radiation Test equipment

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
EMI Test Receiver	R&S	ESCI	102086	2017.10.15	2018.10.14
Bilog Antenna	TESEQ	CBL6111D	34678	2017.11.02	2018.11.01
Horn Antenna	Schwarzbeck	BBHA 9120D (1201)	9120D-1343	2017.10.27	2018.10.26
Passive Loop (9K--30MHz)	ZHNAN	ZN3090C	16035	2018.03.11	2019.03.10
Pre-mpifier (0.1M-3GHz)	EM	EM330	60538	2018.03.11	2019.03.10
PreAmplifier	Agilent	8449B	60538	2017.10.15	2018.10.14
USB RF power sensor	DARE	RPR3006W	15I00041SNO0 3	2017.10.15	2018.10.14
Semi-anechoic chamber	Changling	966	N/A	2017.10.15	2018.10.14

Conduction Test equipment

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
Test Receiver	R&S	ESCI	101427	2017.10.15	2018.10.14
LISN	R&S	ENV216	101242	2017.10.15	2018.10.14
conduction Cable	EM	C01	N/A	2018.03.11	2019.03.10
Temperature & Humidity	Mieo	HH660	N/A	2017.10.15	2018.10.14



Radiation Test equipment

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
Test Receiver	R&S	ESCI	101427	2020.10.12	2021.10.11
Signal Analyzer	R&S	FSV 40-N	101823	2020.10.10	2021.10.09
Active loop Antenna	ZHINAN	ZN30900C	16035	2021.04.11	2023.04.10
Bilog Antenna	TESEQ	CBL6111D	34678	2020.10.12	2022.10.11
Horn Antenna	SCHWARZBECK	BBHA 9120D	02014	2019.10.15	2021.10.14
SHF-EHF Horn Antenna (18G-40GHz)	A-INFO	LB-180400-KF	J211020657	2020.10.12	2022.10.11
Pre-Amplifier(0.1M-3 GHz)	EM	EM330	060665	2020.10.12	2021.10.11
Pre-Amplifier (1G-18GHz)	SKET	LNPA-01018G-45	SK2018080901	2020.10.12	2021.10.11
Pre-Amplifier (18G-40GHz)	SKET	LNPA-1840-50	SK2018101801	2020.10.10	2021.10.09
Temperature & Humidity	HH660	Mieo	N/A	2020.10.13	2021.10.12
Turn table	EM	SC100_1	60531	N/A	N/A
Antenna mast	EM	SC100	N/A	N/A	N/A
Test SW	FARAD	EZ-EMC(Ver.STSLAB-03A1 RE)			

RF Connected Test

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
Power Sensor	Keysight	U2021XA	MY55520005	2020.10.10	2021.10.09
			MY55520006	2020.10.10	2021.10.09
			MY56120038	2020.10.10	2021.10.09
			MY56280002	2020.10.10	2021.10.09
Signal Analyzer	Agilent	N9020A	MY51110105	2021.03.04	2022.03.03
Temperature & Humidity	HH660	Mieo	N/A	2020.10.13	2021.10.12
Test SW	FARAD	LZ-RF /LzRf-3A3			



3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION LIMITS

Operating frequency band. In case the emission fall within the restricted band specified on Part 15.249& RSS-Gen Issue 5 (8.8) limit in the table below has to be followed.

FREQUENCY (MHz)	Class B (dBuV)		Standard
	Quasi-peak	Average	
0.15 -0.5	66 - 56 *	56 - 46 *	CISPR
0.50 -5.0	56.00	46.00	CISPR
5.0 -30.0	60.00	50.00	CISPR

0.15 -0.5	66 - 56 *	56 - 46 *	FCC
0.50 -5.0	56.00	46.00	FCC
5.0 -30.0	60.00	50.00	FCC

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

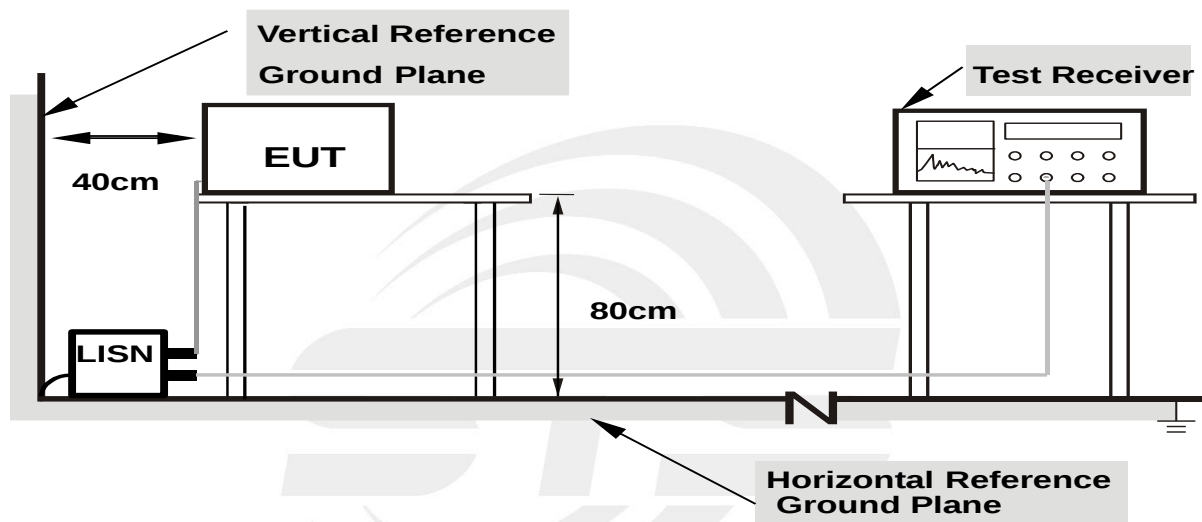
The following table is the setting of the receiver

Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

3.1.2 TEST PROCEDURE

- The EUT was 0.8 meters from the horizontal ground plane and 0.4 meters from the vertical ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- LISN at least 80 cm from nearest part of EUT chassis.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.1.3 TEST SETUP



Note: 1.Support units were connected to second LISN.
2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.4 EUT OPERATING CONDITIONS

The EUT was configured for testing in a typical fashion (as a customer would normally use it). The EUT has been programmed to continuously transmit during test. This operating condition was tested and used to collect the included data.



3.1.5 TEST RESULTS

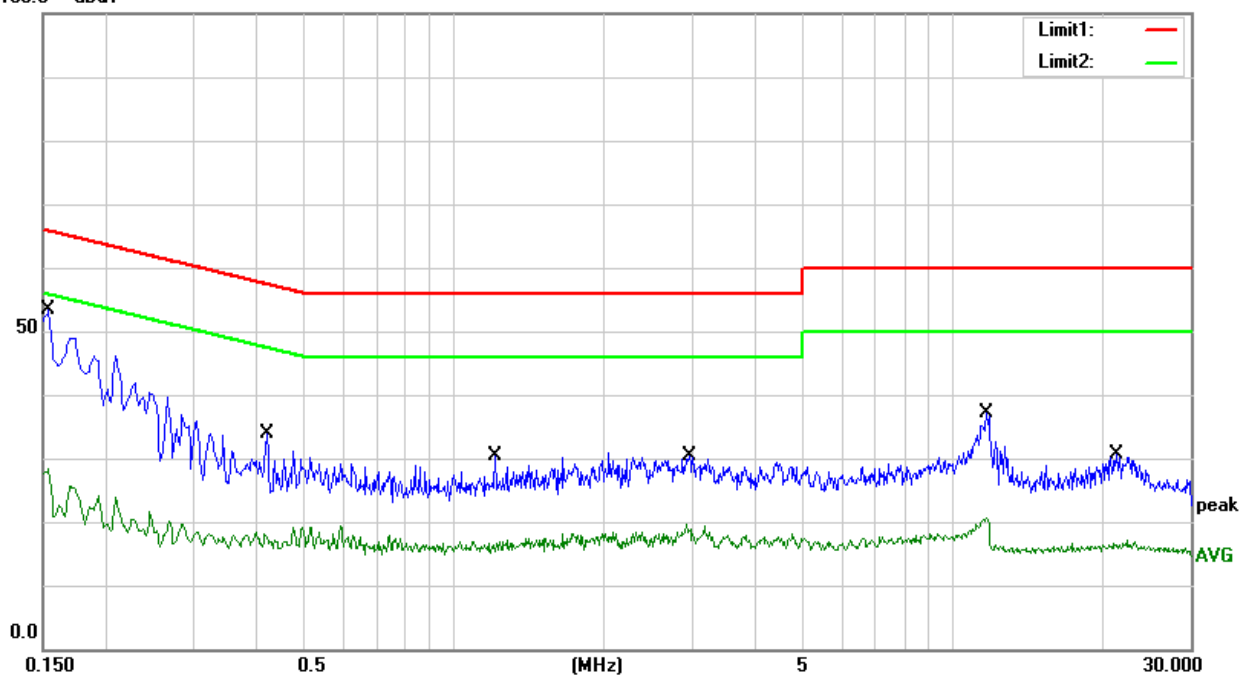
Temperature:	26.5 °C	Relative Humidity:	54%
Test Voltage:	AC 120V/60Hz	Phase:	L
Test Mode:	Mode 4	Chip Manufacture:	STMicroelectronics
Chip Model:	ST32F030C6T6		

Frequency (MHz)	Reading (dBuV)	Correct Factor(dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
0.1540	32.96	20.30	53.26	65.78	-12.52	QP
0.1540	8.02	20.30	28.32	55.78	-27.46	AVG
0.4220	13.40	20.55	33.95	57.41	-23.46	QP
0.4220	-2.51	20.55	18.04	47.41	-29.37	AVG
1.2100	10.07	20.31	30.38	56.00	-25.62	QP
1.2100	-3.48	20.31	16.83	46.00	-29.17	AVG
2.9620	9.86	20.45	30.31	56.00	-25.69	QP
2.9620	-1.61	20.45	18.84	46.00	-27.16	AVG
11.7300	16.07	21.15	37.22	60.00	-22.78	QP
11.7300	-0.54	21.15	20.61	50.00	-29.39	AVG
21.3700	7.78	22.86	30.64	60.00	-29.36	QP
21.3700	-6.34	22.86	16.52	50.00	-33.48	AVG

Remark:

1. All readings are Quasi-Peak and Average values.
2. Margin = Result (Result = Reading + Factor) – Limit

100.0 dBuV



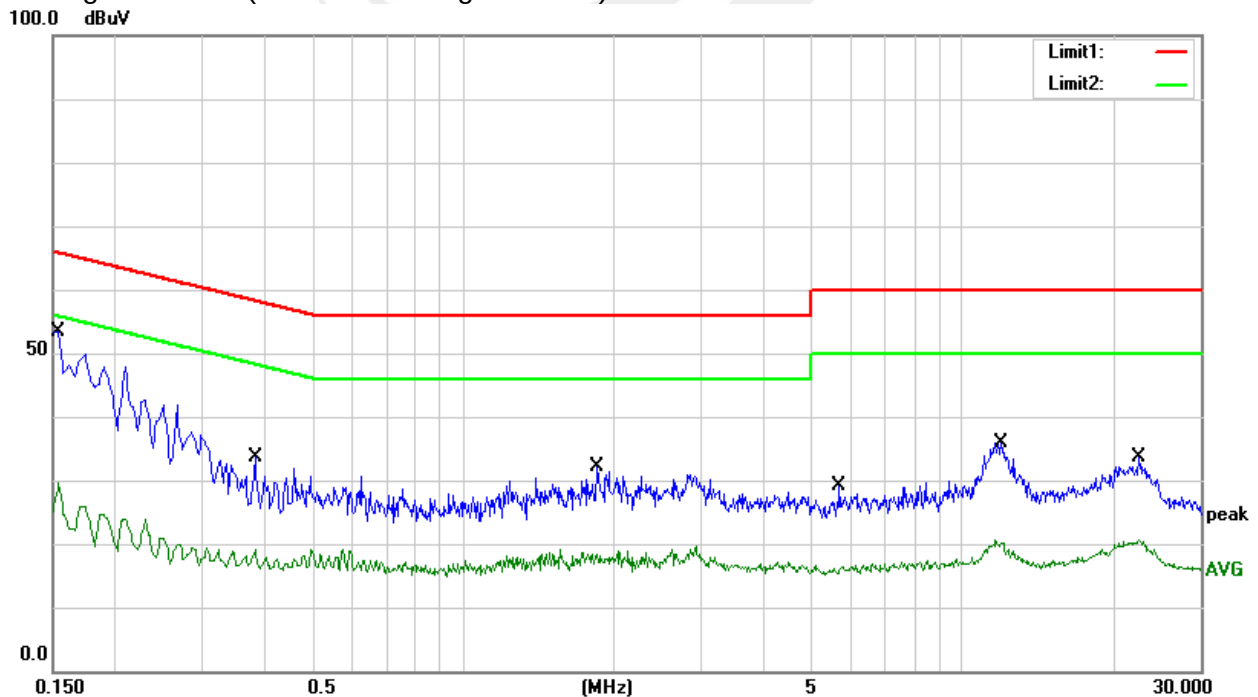


Temperature:	26.5 °C	Relative Humidity:	54%
Test Voltage:	AC 120V/60Hz	Phase:	N
Test Mode:	Mode 4	Chip Manufacture:	STMicroelectronics
Chip Model:	ST32F030C6T6		

Frequency (MHz)	Reading (dBuV)	Correct Factor(dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
0.1540	33.01	20.30	53.31	65.78	-12.47	QP
0.1540	9.22	20.30	29.52	55.78	-26.26	AVG
0.3820	12.92	20.61	33.53	58.24	-24.71	QP
0.3820	-1.39	20.61	19.22	48.24	-29.02	AVG
1.8500	11.67	20.38	32.05	56.00	-23.95	QP
1.8500	-1.90	20.38	18.48	46.00	-27.52	AVG
5.6820	8.52	20.55	29.07	60.00	-30.93	QP
5.6820	-4.21	20.55	16.34	50.00	-33.66	AVG
11.9340	14.80	21.17	35.97	60.00	-24.03	QP
11.9340	-0.52	21.17	20.65	50.00	-29.35	AVG
22.6340	10.75	22.81	33.56	60.00	-26.44	QP
22.6340	-2.23	22.81	20.58	50.00	-29.42	AVG

Remark:

1. All readings are Quasi-Peak and Average values.
2. Margin = Result (Result = Reading + Factor) - Limit



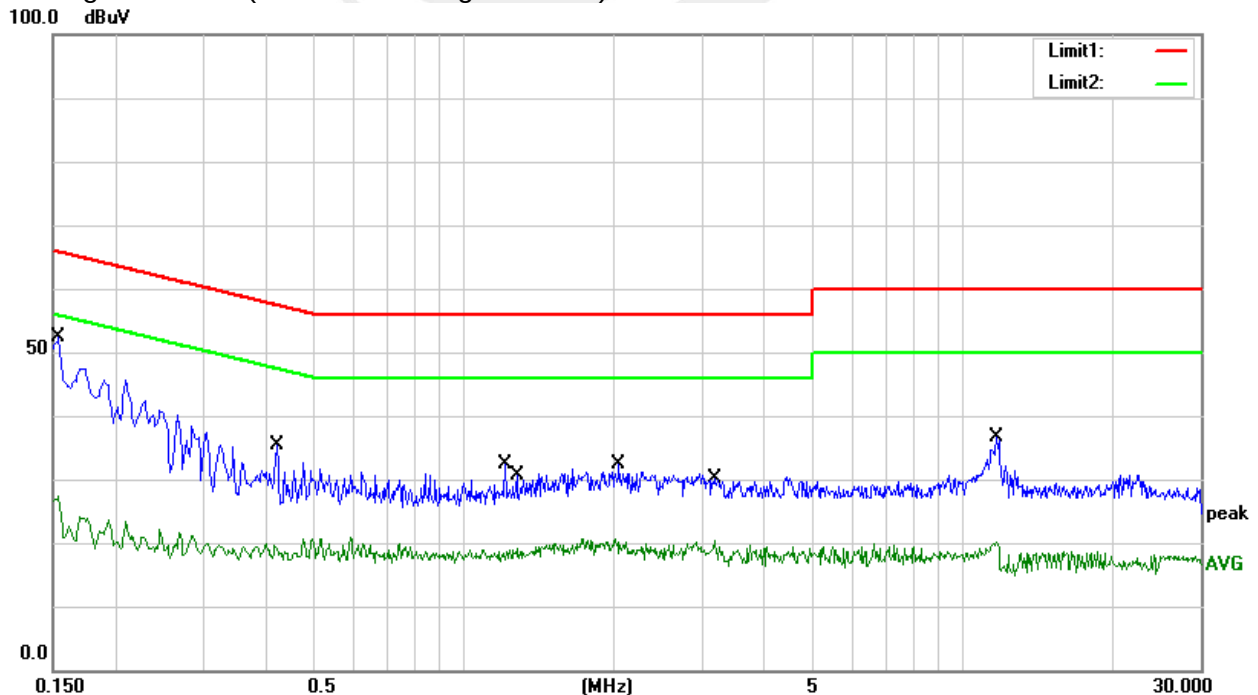


Temperature:	26.5 °C	Relative Humidity:	54%
Test Voltage:	AC 120V/60Hz	Phase:	L
Test Mode:	Mode 4	Chip Manufacture:	Geehy Semiconductor Co.,Ltd.
Chip Model:	APM32F030C8T6		

Frequency (MHz)	Reading (dBuV)	Correct Factor(dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
0.1540	31.96	20.30	52.26	65.78	-13.52	QP
0.1540	7.02	20.30	27.32	55.78	-28.46	AVG
0.4220	14.90	20.55	35.45	57.41	-21.96	QP
0.4220	0.17	20.55	20.72	47.41	-26.69	AVG
1.2100	12.07	20.31	32.38	56.00	-23.62	QP
1.2780	-1.23	20.33	19.10	46.00	-26.90	AVG
2.0460	11.92	20.39	32.31	56.00	-23.69	QP
2.0460	0.32	20.39	20.71	46.00	-25.29	AVG
3.1860	9.58	20.47	30.05	56.00	-25.95	QP
3.1860	-0.15	20.47	20.32	46.00	-25.68	AVG
11.7300	15.57	21.15	36.72	60.00	-23.28	QP
11.7300	-1.04	21.15	20.11	50.00	-29.89	AVG

Remark:

1. All readings are Quasi-Peak and Average values.
2. Margin = Result (Result = Reading + Factor)-Limit



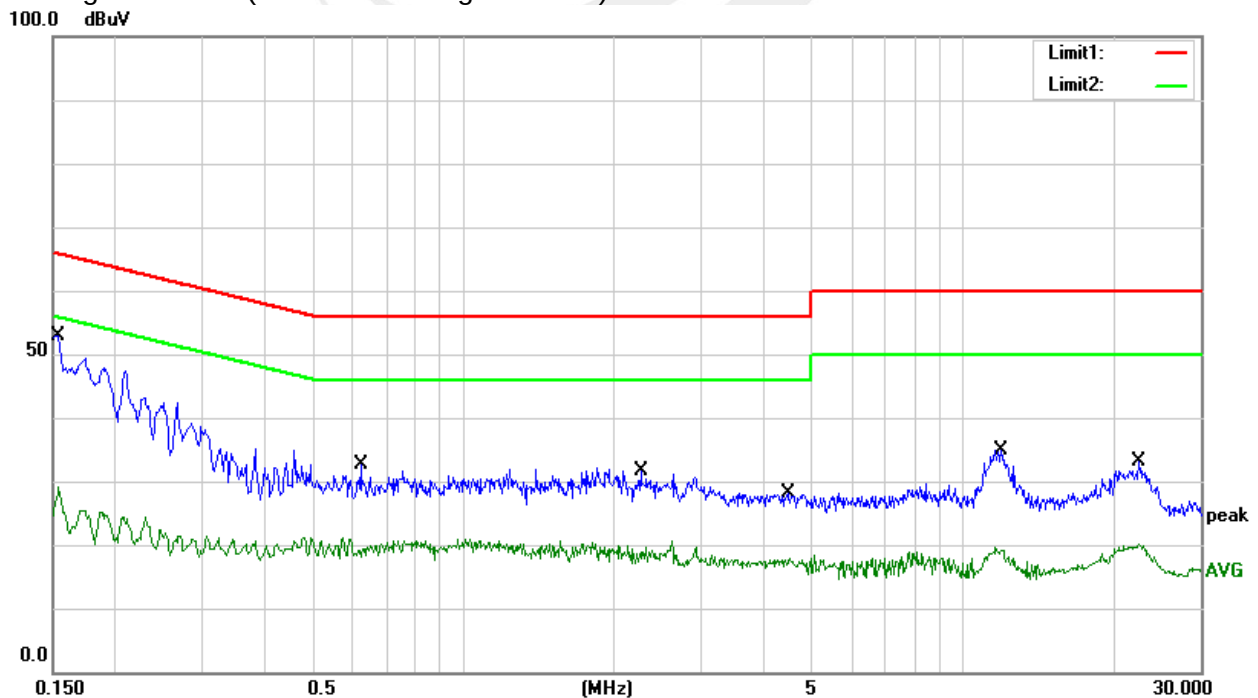


Temperature:	26.5 °C	Relative Humidity:	54%
Test Voltage:	AC 120V/60Hz	Phase:	N
Test Mode:	Mode 4	Chip Manufacture:	Geehy Semiconductor Co.,Ltd.
Chip Model:	APM32F030C8T6		

Frequency (MHz)	Reading (dBuV)	Correct Factor(dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
0.1540	32.51	20.30	52.81	65.78	-12.97	QP
0.1540	8.72	20.30	29.02	55.78	-26.76	AVG
0.6220	12.21	20.42	32.63	56.00	-23.37	QP
0.6220	0.72	20.42	21.14	46.00	-24.86	AVG
2.2700	11.13	20.41	31.54	56.00	-24.46	QP
2.2700	-0.41	20.41	20.00	46.00	-26.00	AVG
4.4940	7.63	20.52	28.15	56.00	-27.85	QP
4.4940	-2.18	20.52	18.34	46.00	-27.66	AVG
11.9340	13.80	21.17	34.97	60.00	-25.03	QP
11.9340	-1.52	21.17	19.65	50.00	-30.35	AVG
22.6340	10.25	22.81	33.06	60.00	-26.94	QP
22.6340	-2.73	22.81	20.08	50.00	-29.92	AVG

Remark:

1. All readings are Quasi-Peak and Average values.
2. Margin = Result (Result =Reading + Factor)-Limit





3.2 RADIATED EMISSION MEASUREMENT

3.2.1 RADIATED EMISSION LIMITS

20dBc in any 100 kHz bandwidth outside the operating frequency band. In case the emission fall within the restricted band specified on Part 15.249 and the Part 15.209(a) limit in the table below has to be followed.

Standard FCC 15.209

Frequencies (MHz)	Field Strength (micorvolts/meter)	Measurement Distance (meters)
0.009~0.490	2400/F(KHz)	300
0.490~1.705	24000/F(KHz)	30
1.705~30.0	30	30
30~88	100	3
88~216	150	3
216~960	200	3
960~1000	500	3
Above 1000	Other:74.0 dB(μV)/m (Peak) 54.0 dB(μV)/m (Average)	3

Standard FCC 15.249

Frequency of Emission (MHz)	Field Strength of fundamental (millivolts /meter)	Field Strength of Harmonics (microvolts/meter)
900~928	50	500
2400~2483.5	50	500
5725~5875	50	500
24000~242500	250	2500

Notes:

- (1) Emissions radiated outside of the specified frequency bands, except for harmonics, shall be attenuated by at least 50 dB below the level of the fundamental or to the general radiated emission limits in Section 15.209, whichever is the lesser attenuation.

In case the emission fall within the restricted band specified on RSS-Gen Issue 5 limit in the followed

. In measuring unwanted emissions, the spectrum shall be investigated from 30 MHz or the lowest radio frequency signal generated in the equipment, whichever is lower, without going below 9 kHz, up to at least the frequency given below:

(a) If the equipment operates below 10 GHz to the tenth harmonic of the highest fundamental frequency or to 40 GHz, whichever is lower.

(b) If the equipment operates at or above 10 GHz: to the fifth harmonic of the highest fundamental frequency or to 100 GHz, whichever is lower.

Particular attention should be paid to harmonics and sub-harmonics of the carrier frequency, as well as to those frequencies removed from the carrier by multiples of the oscillator frequency. Radiation at the frequencies of multiplier stages should also be checked.

The amplitude of spurious emissions attenuated more than 20 dB below the permissible value need not be reported.

When limits are expressed in absolute terms, compliance with the emission limits below 1000 MHz shall be demonstrated using a CISPR quasi-peak detector and the related measurement bandwidth. As an alternative to CISPR quasi-peak measurement, compliance with the emission limits can be demonstrated using measuring equipment employing a peak detector function properly adjusted for factors such as pulse desensitization as required, with an equal or greater measurement bandwidth relative to the applicable CISPR quasi-peak bandwidth.

Above 1000 MHz, compliance with the emission limits shall be demonstrated using an average detector with a minimum resolution bandwidth of 1 MHz.

In case the emission fall within the restricted band specified on RSS 210 Issue 10 (B.10) limit in the followed

1. The field strength of fundamental and harmonic emissions, measured at 3 m, shall not exceed 50 mV/m and 0.5 mV/m respectively.

The field strength limits shall be measured using an average detector, except for the fundamental emission in the frequency band 902-928 MHz, which is based on measurements using an International Special Committee on Radio Interference (CISPR) quasi-peak detector.

2. Emissions radiated outside of the specified frequency bands, except for harmonic emissions, shall be attenuated by at least 50 dB below the level of the fundamental emissions or to the general field strength limits listed in RSS-Gen, whichever is less stringent.

NOTE:

(1)The limit for radiated test was performed according to RSS 210 Issue 10

(2)Emission level (dBuV/m)=20log Emission level (uV/m).



Spectrum Parameter	Setting
Detector	Peak/AV
Attenuation	Auto
Start Frequency	1000 MHz
Stop Frequency	10th carrier harmonic
RB (emission in restricted band)	>20BW
VB (emission in restricted band)	=3xRB

Receiver Parameter	Setting
Attenuation	Auto
Start ~ Stop Frequency	9kHz~90kHz / RB 200Hz for PK & AV
	90kHz~110kHz / RB 200Hz for QP
	110kHz~490kHz / RB 200Hz for PK & AV
	490kHz~30MHz / RB 9kHz for QP
	30MHz~1000MHz / RB 120kHz for QP

3.2.2 TEST PROCEDURE

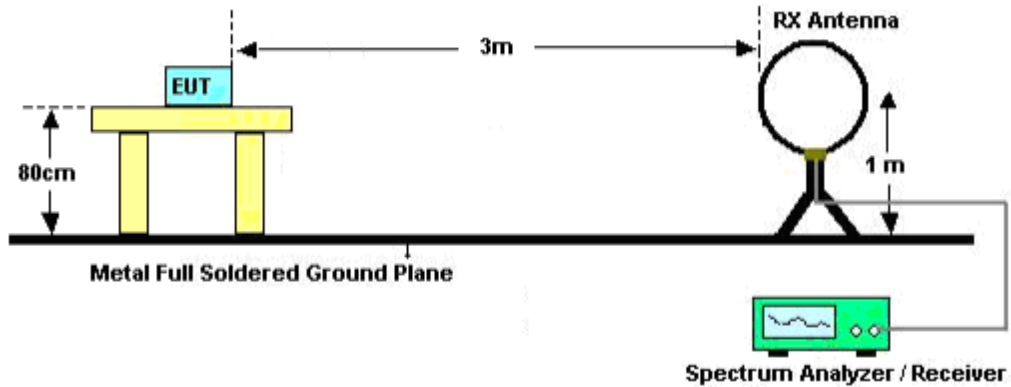
- The measuring distance of 3m shall be used for measurements. The EUT was placed on the top of a rotating table 0.8 meter above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation (Below 1GHz)
- The measuring distance of 3m shall be used for measurements. The EUT was placed on the top of a rotating table 1.5 meter above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation (Above 1GHz)
- The height of the test antenna shall vary between 1m to 4m. Both horizontal and vertical polarization of the antenna are set to make the measurement.
- The initial step in collecting radiated emission data is a receive peak detector mode. Pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- All readings are peak unless otherwise stated QP in column of Note. Peak denotes that the Peak reading complies with the QP limits and then QP Mode measurement didn't perform (Below 1GHz)
- All readings are Peak mode value unless otherwise stated AVG in column of Note. If the Peak mode measured value complies with the Peak limits and lower than AVG Limits, the EUT shall be deemed to meet Peak & AVG limits and then only Peak mode was measured, but AVG mode didn't perform. (Above 1GHz)
- For the actual test configuration, please refer to the related Item –EUT Test Photos.
Note: Both horizontal and vertical antenna polarities were tested and performed pretest to three orthogonal axes. The worst case emissions were reported

3.2.3 DEVIATION FROM TEST STANDARD

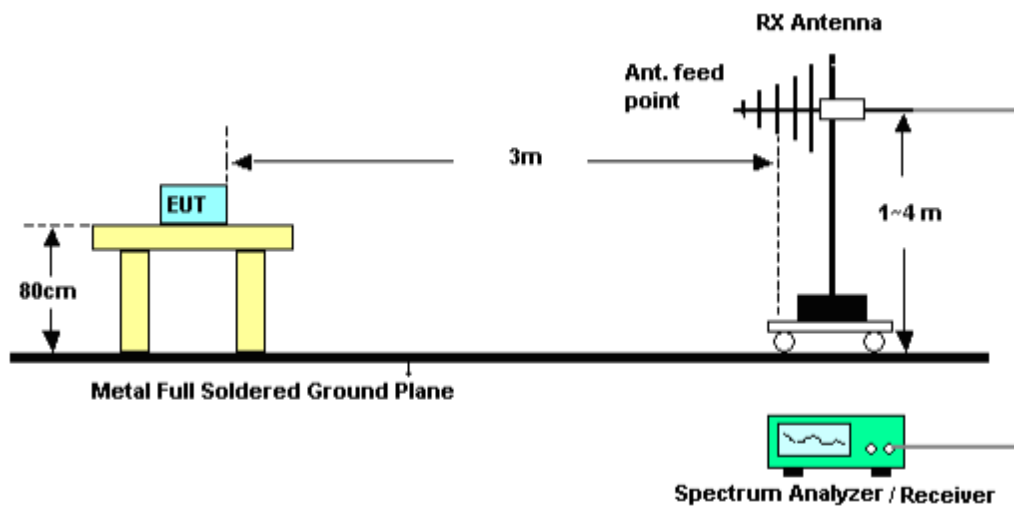
No deviation

3.2.4 TEST SETUP

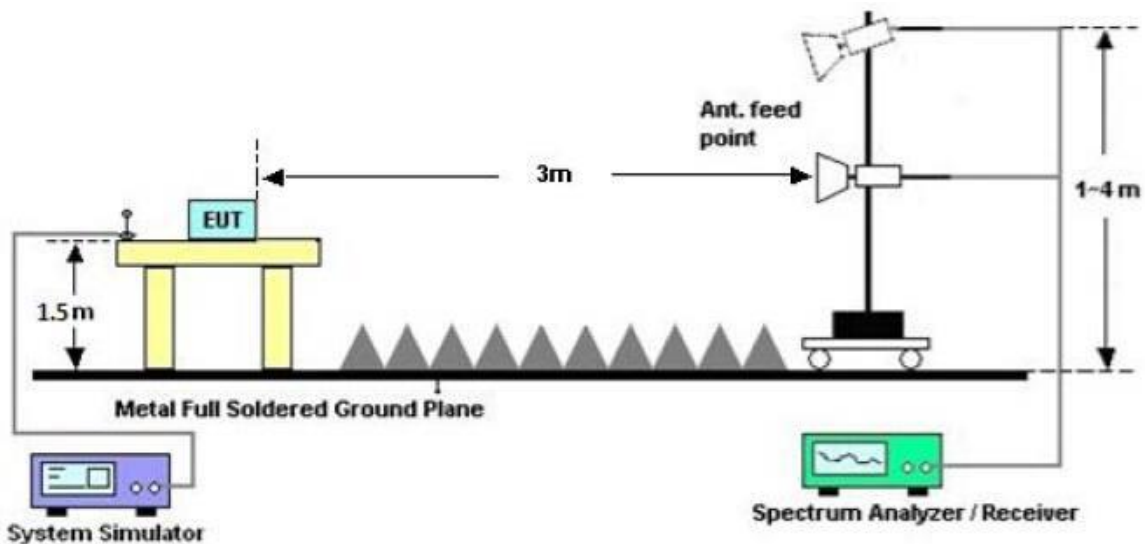
(A) Radiated Emission Test-Up Frequency Below 30MHz



(B) Radiated Emission Test-Up Frequency 30MHz~1GHz



(C) Radiated Emission Test-Up Frequency Above 1GHz





3.2.5 FIELD STRENGTH CALCULATION

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor (if any) from the measured reading. The basic equation with a sample calculation is as follows:

$$FS = RA + AF + CL - AG$$

Where

FS = Field Strength

CL = Cable Attenuation Factor (Cable Loss)

RA = Reading Amplitude

AG = Amplifier Gain

AF = Antenna Factor

For example

Frequency	FS	RA	AF	CL	AG	Factor
(MHz)	(dBμV/m)	(dBμV/m)	(dB)	(dB)	(dB)	(dB)
300	40	58.1	12.2	1.6	31.9	-18.1

$$\text{Factor} = \text{AF} + \text{CL} - \text{AG}$$

3.2.6 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.4 Unless otherwise a special operating condition is specified in the follows during the testing.

Below 30 MHz

Temperature:	25.2 °C	Relative Humidity:	50%
Test Voltage:	DC 30V	Polarization:	---
Test Mode:	TX Mode		

Freq.	Reading	Limit	Margin	State
(MHz)	(dBuV/m)	(dBuV/m)	(dB)	P/F
--	--	--	--	PASS
--	--	--	--	PASS

NOTE:

The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

Distance extrapolation factor = $40 \log (\text{specific distance/test distance})$ (dB);

Limit line = specific limits(dBuV) + distance extrapolation factor.



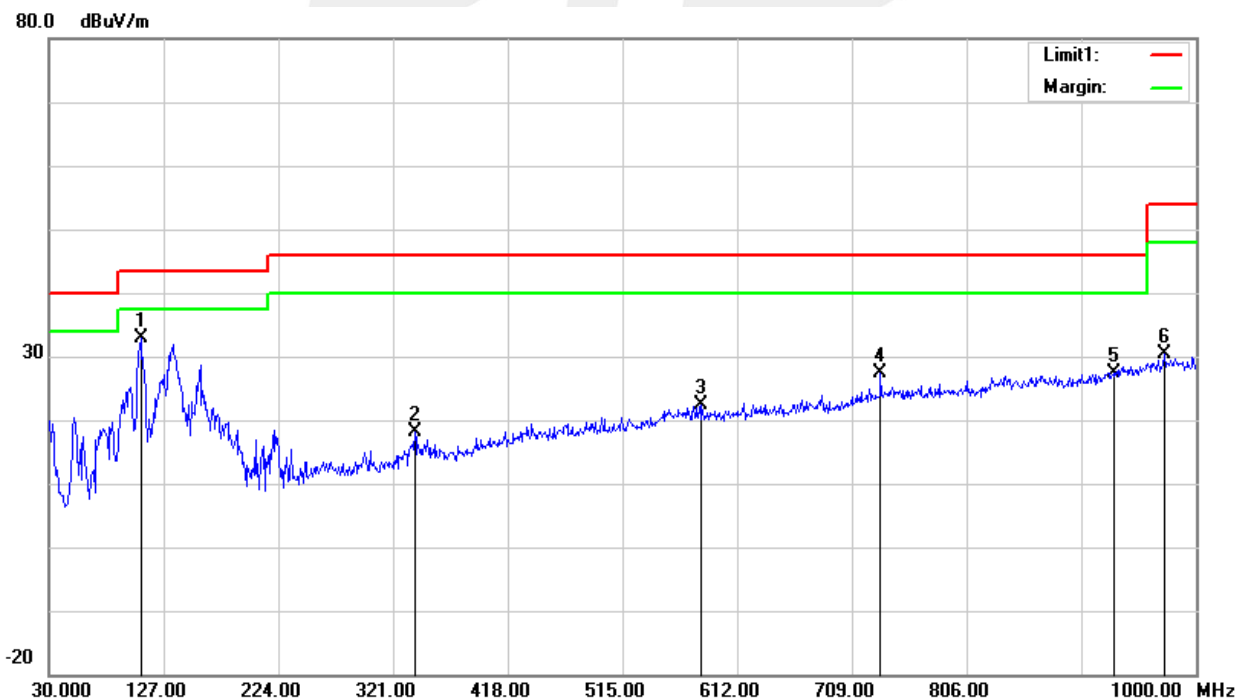
Between 30MHz – 1000 MHz Radiation Spurious

Temperature:	23.1 °C	Relative Humidity:	60%
Test Voltage:	DC 30V	Phase:	Horizontal
Test Mode:	Mode1/2/3(Mode 1 worst mode)	Chip Manufacture:	STMicroelectronics
Chip Model:	ST32F030C6T6		

Frequency (MHz)	Reading (dBuV)	Correct Factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
107.6000	52.10	-19.32	32.78	43.50	-10.72	QP
339.4300	31.63	-13.43	18.20	46.00	-27.80	QP
581.9300	28.11	-5.78	22.33	46.00	-23.67	QP
733.2500	29.72	-2.35	27.37	46.00	-18.63	QP
931.1300	26.76	0.64	27.40	46.00	-18.60	QP
972.8400	28.26	2.19	30.45	54.00	-23.55	QP

Remark:

1. Margin = Result (Result = Reading + Factor) – Limit





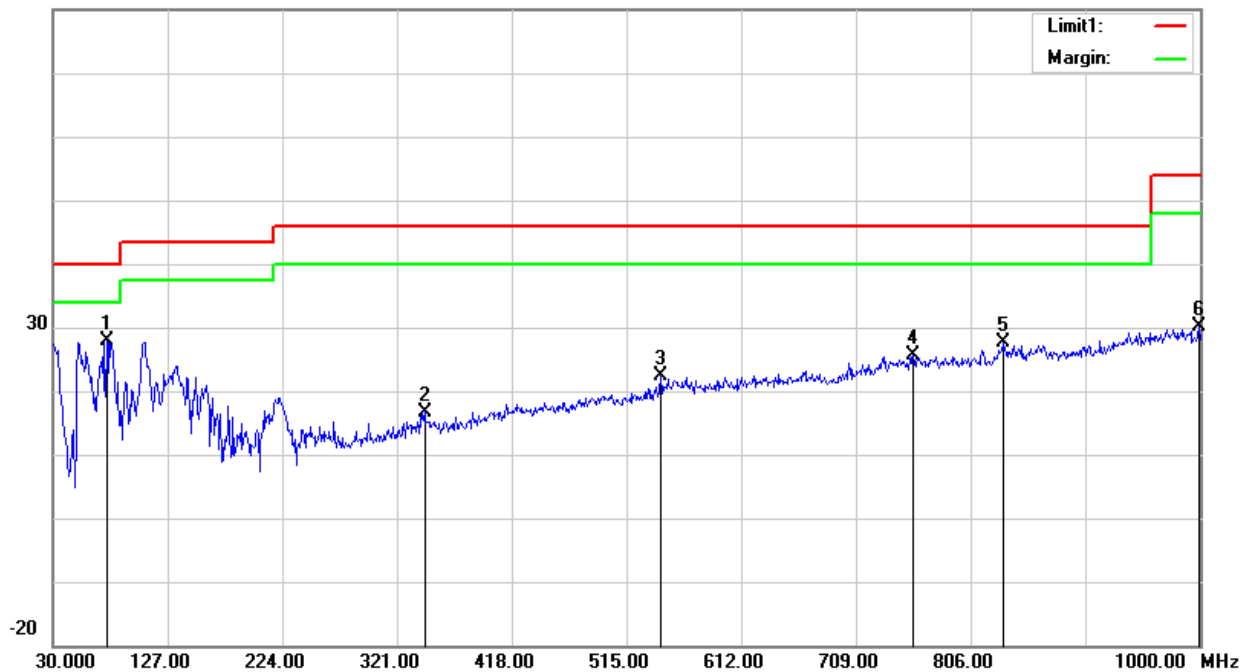
Temperature:	23.1 °C	Relative Humidity:	60%
Test Voltage:	DC 30V	Phase:	Vertical
Test Mode:	Mode1/2/3(Mode 1 worst mode)	Chip Manufacture:	STMicroelectronics
Chip Model:	ST32F030C6T6		

Frequency	Reading	Correct	Result	Limit	Margin	Remark
(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
75.5900	51.76	-23.78	27.98	40.00	-12.02	QP
344.2800	30.01	-13.26	16.75	46.00	-29.25	QP
544.1000	28.69	-6.41	22.28	46.00	-23.72	QP
757.5000	27.75	-2.17	25.58	46.00	-20.42	QP
833.1600	28.20	-0.62	27.58	46.00	-18.42	QP
999.0300	27.98	2.04	30.02	54.00	-23.98	QP

Remark:

1. Margin = Result (Result =Reading + Factor)–Limit

80.0 dBuV/m





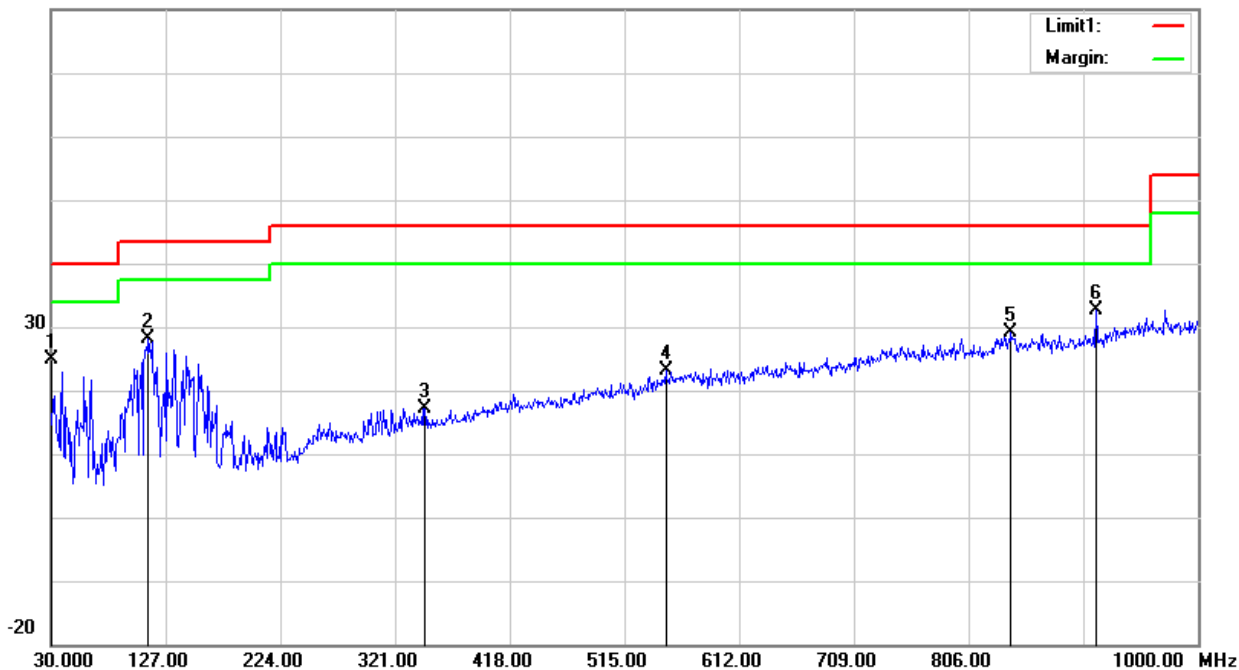
Temperature:	23.1 °C	Relative Humidity:	60%
Test Voltage:	DC 30V	Phase:	Horizontal
Test Mode:	Mode1/2/3(Mode 1 worst mode)	Chip Manufacture:	Geehy Semiconductor Co.,Ltd.
Chip Model:	APM32F030C8T6		

Frequency (MHz)	Reading (dBuV)	Correct Factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
30.0000	37.79	-12.85	24.94	40.00	-15.06	QP
112.4500	47.03	-18.82	28.21	43.50	-15.29	QP
346.2200	30.38	-13.19	17.19	46.00	-28.81	QP
549.9200	28.98	-5.78	23.20	46.00	-22.80	QP
841.8900	29.62	-0.42	29.20	46.00	-16.80	QP
913.6700	32.84	-0.13	32.71	46.00	-13.29	QP

Remark:

1. Margin = Result (Result = Reading + Factor) – Limit

80.0 dBuV/m





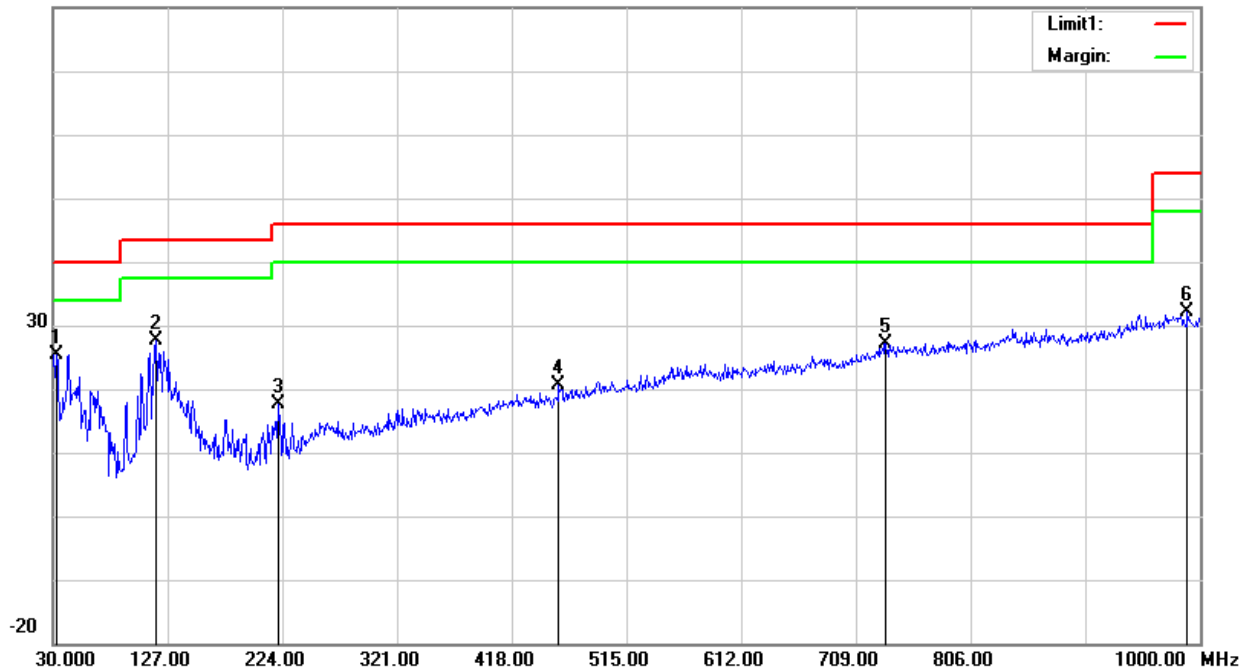
Temperature:	23.1 °C	Relative Humidity:	60%
Test Voltage:	DC 30V	Phase:	Vertical
Test Mode:	Mode1/2/3(Mode 1 worst mode)	Chip Manufacture:	Geehy Semiconductor Co.,Ltd.
Chip Model:	APM32F030C8T6		

Frequency	Reading	Correct	Result	Limit	Margin	Remark
(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
32.9100	39.77	-14.33	25.44	40.00	-14.56	QP
117.3000	46.10	-18.47	27.63	43.50	-15.87	QP
220.1200	37.13	-19.59	17.54	46.00	-28.46	QP
457.7700	30.11	-9.51	20.60	46.00	-25.40	QP
734.2200	29.52	-2.31	27.21	46.00	-18.79	QP
989.3300	30.12	2.09	32.21	54.00	-21.79	QP

Remark:

1. Margin = Result (Result =Reading + Factor)–Limit

80.0 dBuV/m





Fundamental frequency:

PK

Frequency (MHz)	Reading (dBμV/m)	Amplifier	Loss	Antenna Factor	Factor(dB)	Result (dBμV/m)	Limit (dBμV/m)	Margin(dB)	Polarization
	PEAK	(dB)	(dB)	(dB/m)	Corr.	PEAK	PEAK	PEAK	
2403	99.819	44.40	6.03	27.60	-10.77	89.05	114	-24.95	Vertical
2403	97.914	44.40	6.03	27.60	-10.77	87.15	114	-26.85	Horizontal
2440	99.477	44.40	6.04	27.63	-10.73	88.75	114	-25.25	Vertical
2440	97.820	44.40	6.04	27.63	-10.73	87.09	114	-26.91	Horizontal
2480	98.426	44.40	6.06	27.66	-10.68	87.75	114	-26.25	Vertical
2480	96.739	44.40	6.06	27.66	-10.68	86.06	114	-27.94	Horizontal

AV

Frequency (MHz)	Reading (dBμV/m)	Amplifier	Loss	Antenna Factor	Factor(dB)	Result (dBμV/m)	Limit (dBμV/m)	Margin(dB)	Polarization
	AV	(dB)	(dB)	(dB/m)	Corr.	AV	AV	AV	
2403	84.769	44.40	6.03	27.60	-10.77	74.00	94	-20.00	Vertical
2403	83.536	44.40	6.03	27.60	-10.77	72.77	94	-21.23	Horizontal
2440	82.169	44.40	6.04	27.63	-10.73	71.44	94	-22.56	Vertical
2440	81.782	44.40	6.04	27.63	-10.73	71.06	94	-22.94	Horizontal
2480	81.316	44.40	6.06	27.66	-10.68	70.64	94	-23.36	Vertical
2480	79.927	44.40	6.06	27.66	-10.68	69.25	94	-24.75	Horizontal

Note: RBW>20BW; VBW=3xRBW



Above 1G Radiation Spurious

Frequency	Reading	Amplifier	Loss	Antenna	Corrected	Emission	Limits	Margin	Detector	Comment
(MHz)	(dBμV)	(dB)	(dB)	Factor	Factor	Level	(dBμV/m)	(dB)	Type	
Low Channel (2403 MHz)										
3264.73	47.88	44.70	6.70	28.20	-9.80	38.08	74.00	-35.92	PK	Vertical
3264.73	39.79	44.70	6.70	28.20	-9.80	29.99	54.00	-24.01	AV	Vertical
3264.62	48.20	44.70	6.70	28.20	-9.80	38.40	74.00	-35.60	PK	Horizontal
3264.62	39.23	44.70	6.70	28.20	-9.80	29.43	54.00	-24.57	AV	Horizontal
4806.32	58.87	44.20	9.04	31.60	-3.56	55.31	74.00	-18.69	PK	Vertical
4806.32	38.75	44.20	9.04	31.60	-3.56	35.19	54.00	-18.81	AV	Vertical
4806.33	58.67	44.20	9.04	31.60	-3.56	55.11	74.00	-18.89	PK	Horizontal
4806.33	38.55	44.20	9.04	31.60	-3.56	34.99	54.00	-19.01	AV	Horizontal
5359.78	45.59	44.20	9.86	32.00	-2.34	43.25	74.00	-30.75	PK	Vertical
5359.78	38.08	44.20	9.86	32.00	-2.34	35.74	54.00	-18.26	AV	Vertical
5359.68	45.65	44.20	9.86	32.00	-2.34	43.31	74.00	-30.69	PK	Horizontal
5359.68	38.25	44.20	9.86	32.00	-2.34	35.91	54.00	-18.09	AV	Horizontal
7208.95	50.81	43.50	11.40	35.50	3.40	54.21	74.00	-19.79	PK	Vertical
7208.95	32.72	43.50	11.40	35.50	3.40	36.12	54.00	-17.88	AV	Vertical
7208.81	51.13	43.50	11.40	35.50	3.40	54.53	74.00	-19.47	PK	Horizontal
7208.81	33.19	43.50	11.40	35.50	3.40	36.59	54.00	-17.41	AV	Horizontal



Frequency	Reading	Amplifier	Loss	Antenna	Corrected	Emission	Limits	Margin	Detector	Comment
(MHz)	(dBμV)	(dB)	(dB)	Factor	Factor	Level	(dBμV/m)	(dB)	Type	
Middle Channel (2440 MHz)										
3264.87	48.14	44.70	6.70	28.20	-9.80	38.34	74.00	-35.66	PK	Vertical
3264.87	37.83	44.70	6.70	28.20	-9.80	28.03	54.00	-25.97	AV	Vertical
3264.81	48.16	44.70	6.70	28.20	-9.80	38.36	74.00	-35.64	PK	Horizontal
3264.81	38.32	44.70	6.70	28.20	-9.80	28.52	54.00	-25.48	AV	Horizontal
4880.31	59.41	44.20	9.04	31.60	-3.56	55.85	74.00	-18.15	PK	Vertical
4880.31	38.64	44.20	9.04	31.60	-3.56	35.08	54.00	-18.92	AV	Vertical
4880.50	58.52	44.20	9.04	31.60	-3.56	54.96	74.00	-19.04	PK	Horizontal
4880.50	39.25	44.20	9.04	31.60	-3.56	35.69	54.00	-18.31	AV	Horizontal
5359.62	45.30	44.20	9.86	32.00	-2.34	42.96	74.00	-31.04	PK	Vertical
5359.62	37.41	44.20	9.86	32.00	-2.34	35.07	54.00	-18.93	AV	Vertical
5359.67	46.31	44.20	9.86	32.00	-2.34	43.97	74.00	-30.03	PK	Horizontal
5359.67	37.98	44.20	9.86	32.00	-2.34	35.64	54.00	-18.36	AV	Horizontal
7320.76	51.30	43.50	11.40	35.50	3.40	54.70	74.00	-19.30	PK	Vertical
7320.76	33.73	43.50	11.40	35.50	3.40	37.13	54.00	-16.87	AV	Vertical
7320.82	50.71	43.50	11.40	35.50	3.40	54.11	74.00	-19.89	PK	Horizontal
7320.82	33.66	43.50	11.40	35.50	3.40	37.06	54.00	-16.94	AV	Horizontal



Frequency (MHz)	Reading (dBμV)	Amplifier (dB)	Loss (dB)	Antenna Factor (dB/m)	Corrected Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Margin (dB)	Detector Type	Comment
High Channel (2480 MHz)										
3264.75	49.06	44.70	6.70	28.20	-9.80	39.26	74.00	-34.74	PK	Vertical
3264.75	37.84	44.70	6.70	28.20	-9.80	28.04	54.00	-25.96	AV	Vertical
3264.77	48.57	44.70	6.70	28.20	-9.80	38.77	74.00	-35.23	PK	Horizontal
3264.77	39.08	44.70	6.70	28.20	-9.80	29.28	54.00	-24.72	AV	Horizontal
4960.34	59.41	44.20	9.04	31.60	-3.56	55.85	74.00	-18.15	PK	Vertical
4960.34	39.19	44.20	9.04	31.60	-3.56	35.63	54.00	-18.37	AV	Vertical
4960.55	58.92	44.20	9.04	31.60	-3.56	55.36	74.00	-18.64	PK	Horizontal
4960.55	39.41	44.20	9.04	31.60	-3.56	35.85	54.00	-18.15	AV	Horizontal
5359.83	45.46	44.20	9.86	32.00	-2.34	43.12	74.00	-30.88	PK	Vertical
5359.83	37.84	44.20	9.86	32.00	-2.34	35.50	54.00	-18.50	AV	Vertical
5359.78	45.89	44.20	9.86	32.00	-2.34	43.55	74.00	-30.45	PK	Horizontal
5359.78	37.55	44.20	9.86	32.00	-2.34	35.21	54.00	-18.79	AV	Horizontal
7439.78	50.53	43.50	11.40	35.50	3.40	53.93	74.00	-20.07	PK	Vertical
7439.78	33.60	43.50	11.40	35.50	3.40	37.00	54.00	-17.00	AV	Vertical
7439.88	51.08	43.50	11.40	35.50	3.40	54.48	74.00	-19.52	PK	Horizontal
7439.88	33.68	43.50	11.40	35.50	3.40	37.08	54.00	-16.92	AV	Horizontal

Note:

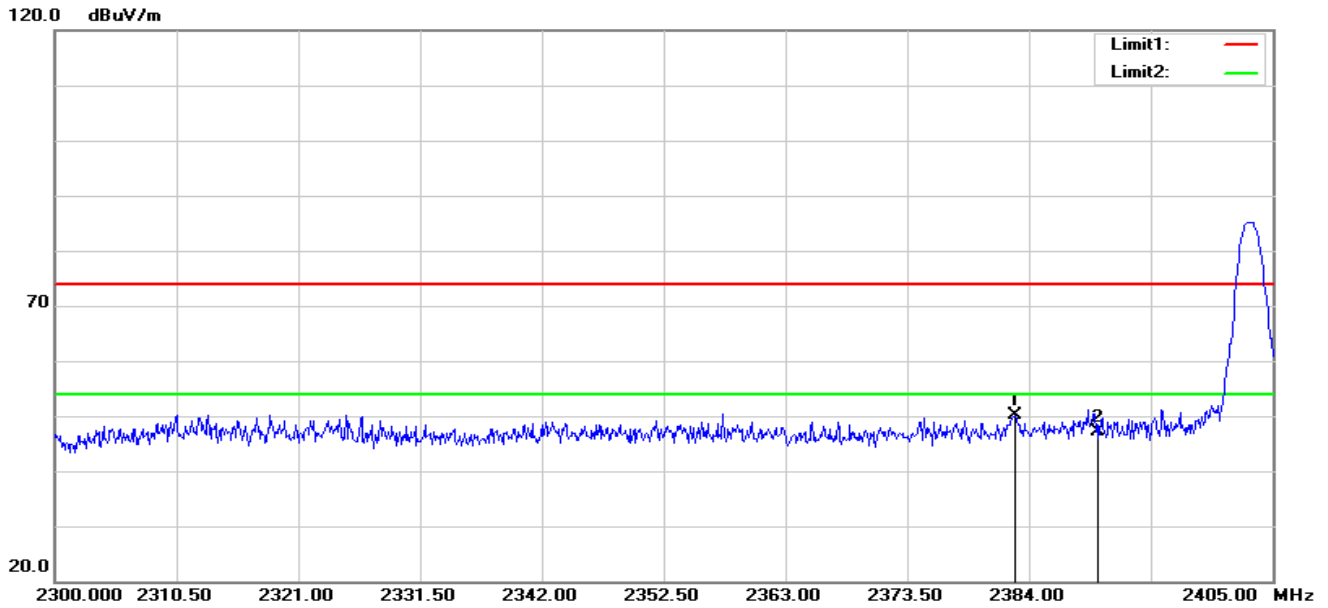
1) Factor = Antenna Factor + Cable Loss – Pre-amplifier.

Emission Level = Reading + Factor

2) The frequency emission of peak points that did not show above the forms are below the limit,
the frequency emission is mainly from the environment noise.

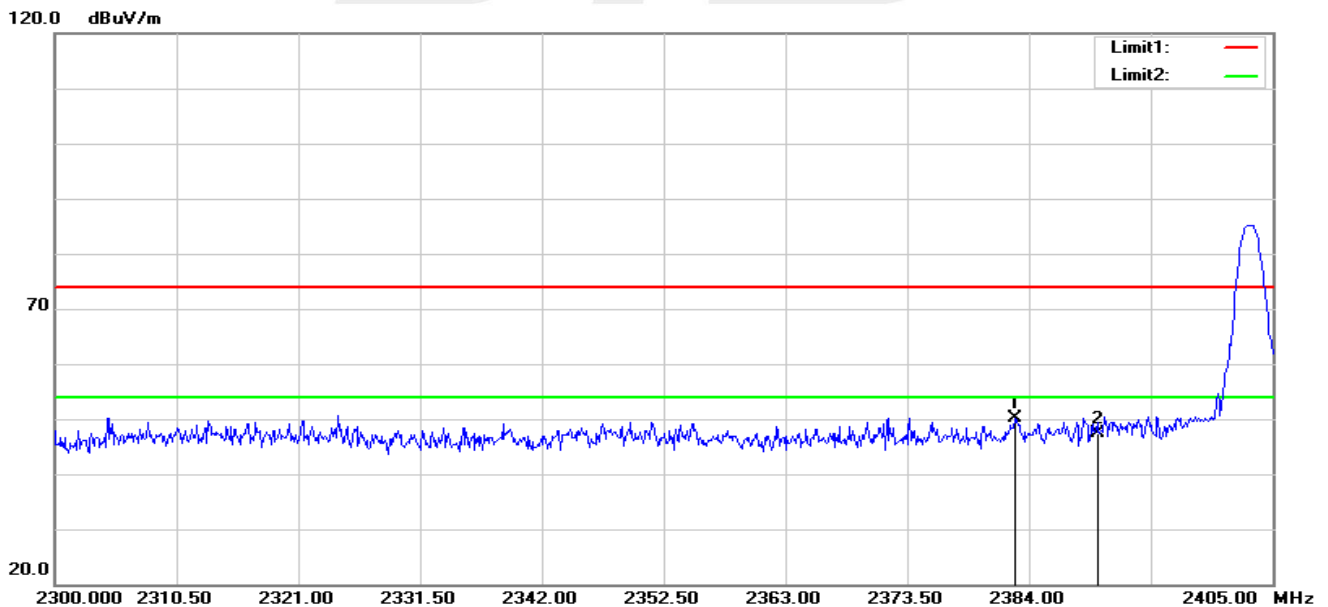


(Radiation Band edge)

GFSK-Low
Horizontal

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	2382.845	52.24	-2.07	50.17	74.00	-23.83	peak
2	2390.000	49.10	-2.02	47.08	74.00	-26.92	peak

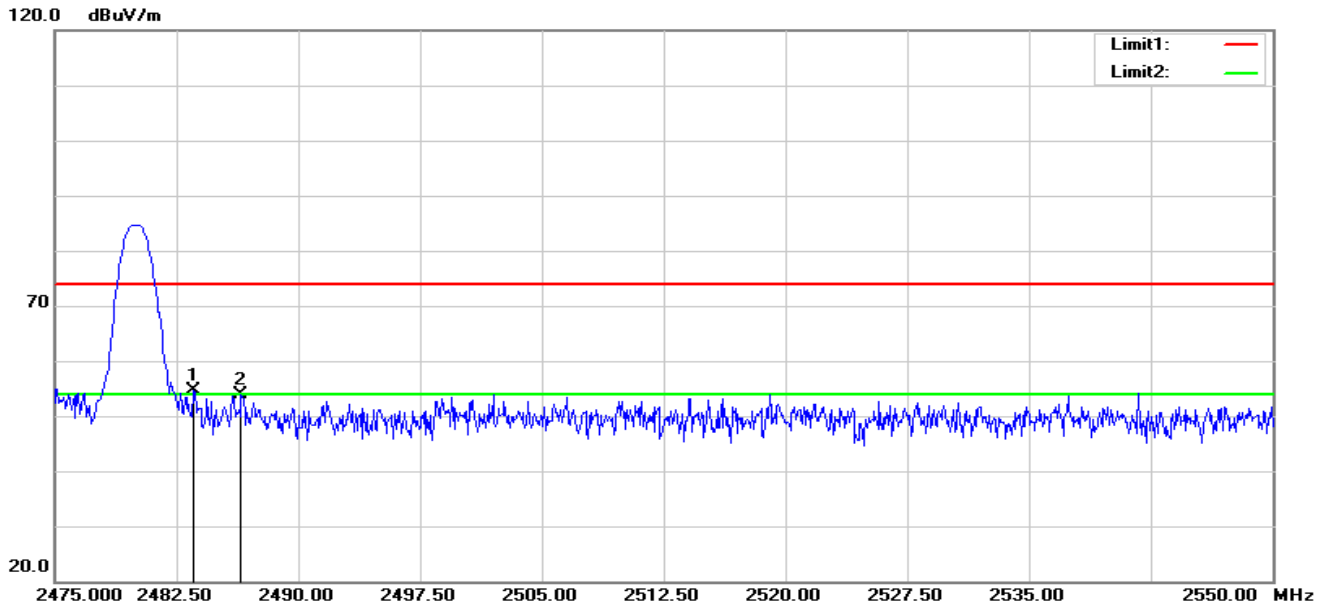
Vertical



No.	Frequency (MHz)	Reading (dBuV)	Correct Factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	2382.845	52.29	-2.07	50.22	74.00	-23.78	peak
2	2390.000	49.40	-2.02	47.38	74.00	-26.62	peak

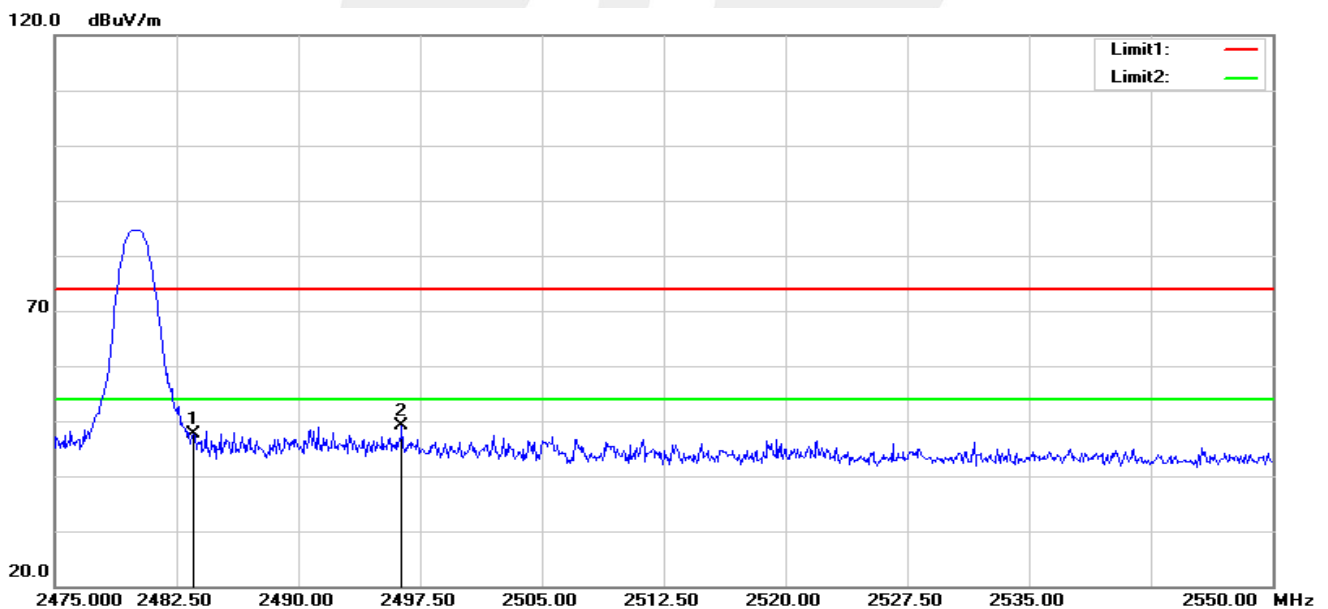


GFSK-High Horizontal



No.	Frequency (MHz)	Reading (dBuV)	Correct Factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	2483.500	56.17	-1.50	54.67	74.00	-19.33	peak
2	2486.475	55.35	-1.49	53.86	74.00	-20.14	peak

Vertical



No.	Frequency (MHz)	Reading (dBuV)	Correct Factor(dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	2483.500	49.18	-1.50	47.68	74.00	-26.32	peak
2	2496.375	50.49	-1.43	49.06	74.00	-24.94	peak



4. BANDWIDTH TEST

4.1 TEST PROCEDURE

- a. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below,
- b. Spectrum Setting : RBW= 30KHz, VBW $\geq$ RBW, Sweep time = Auto.

4.2 TEST SETUP



4.3 EUT OPERATION CONDITIONS

TX mode.



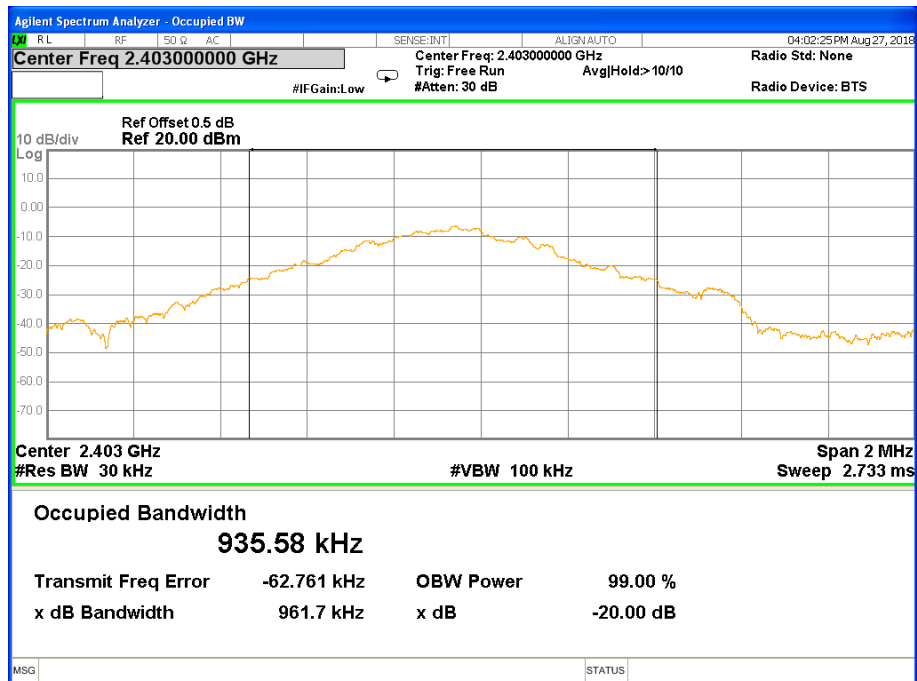


4.4 TEST RESULTS

Temperature:	25 °C	Relative Humidity:	50%
Test Voltage:	AC120V/60Hz		

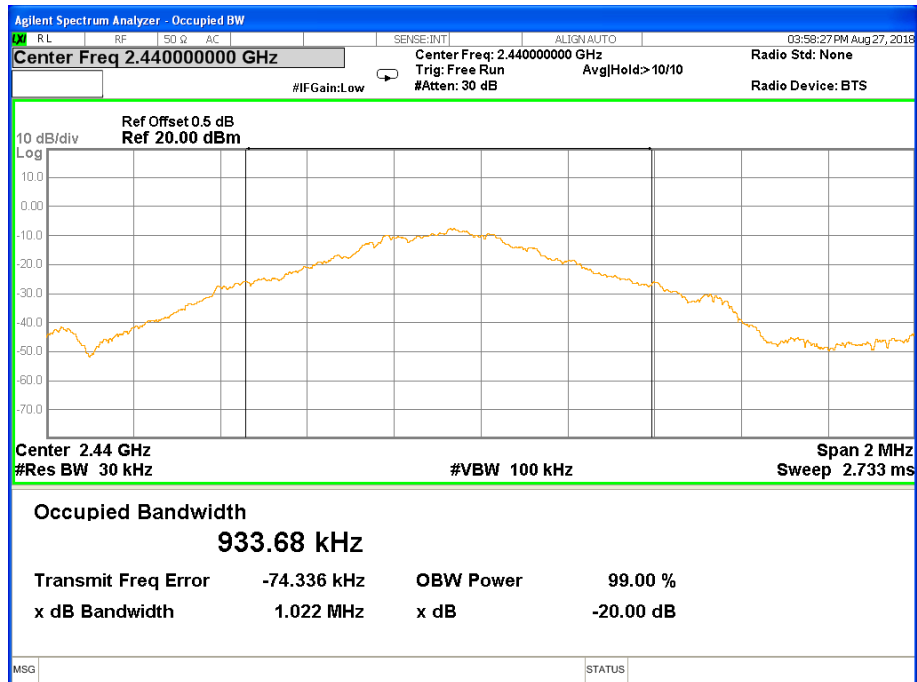
Test Channel	Frequency (MHz)	20 dBc Bandwidth (MHz)	99% Bandwidth (MHz)
CH01	2403	0.962	0.936
CH38	2440	1.022	0.934
CH78	2480	0.956	0.888

The Lowest Channel:2403MHz

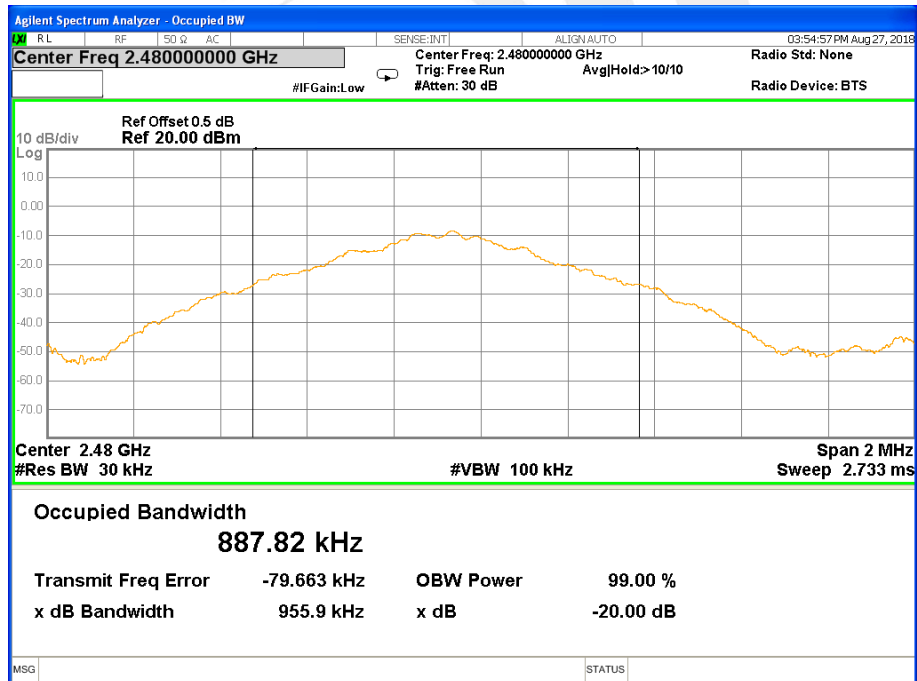




The Middle Channel: 2440MHz



The High Channel: 2480MHz





5. ANTENNA REQUIREMENT

5.1 STANDARD REQUIREMENT

According to the FCC Part 15 Paragraph 15.203& RSS-Gen Issue 5, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

5.2 EUT ANTENNA

The EUT antenna is PCB Antenna.It conforms to the standard requirements.





6.FREQUENCY STABILITY

6.1 LIMITS

The frequency tolerance of the carrier signal shall be maintained within $\pm 0.02\%$ of the operating frequency over a temperature variation of -30 degrees to 50 degrees C at normal supply voltage, and for a variation in primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees.

6.2 TEST PROCEDURE

- 1.The EUT was placed inside the environmental test chamber and powered by nominal DC voltage.
- 2.Turn the EUT on and couple its output to spectrum analyzer.
- 3.Turn the EUT off and set the chamber to the highest temperature specified.
- 4.Allow sufficient time (approximately 30 min) for the temperature of the chamber to stabilize, turn the EUT on and measure the operating frequency after 2, 5, and 10 minutes.
- 5.Repeat step 2 and 3 with the temperature chamber set to the lowest temperature.
- 6.The test chamber was allowed to stabilize at $+20$ degree C for a minimum of 30 minutes. The supply voltage was then adjusted on the EUT from 85% to 115% and the frequency record.

6.3 TEST RESULT

Channel 38 (2440MHz)

Voltage vs. Frequency Stability

Voltage vs. Frequency Stability Voltage(V)	Measurement Frequency(MHz)
34.5	2440.0021
30	2440.0012
25.5	2440.0019
Max.Deviation(MHz)	0.0021
Max.Deviation(ppm)	0.86

Rated working voltage: DC 30V

Temperature vs. Frequency Stability

Temperature($^{\circ}$ C)	Measurement Frequency(MHz)
-30	2440.0029
-20	2440.0023
-10	2440.0025
0	2440.0021
10	2440.0023
20	2440.0022
30	2440.0020
40	2440.0021
50	2440.0023
Max.Deviation(MHz)	0.0029
Max.Deviation(ppm)	1.19



APPENDIX- PHOTOS OF TEST SETUP

Note: See test photos in setup photo document for the actual connections between Product and support equipment.

※※※※※END OF THE REPORT※※※※※

